Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/705,863	HIBINO ET AL.	
Examiner	Art Unit	
Duc M. Nguyen	2685	

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Class	Subclass	Date	Examiner
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	132 32 172		/
	174 227 231	3/6/08	pn

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
Claim	ceard	6/8/06	1800		

SE (INCLUDIN	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR		
EAST		2/21/2006	DN		
EAST		3/6/2006	DN		
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